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List of Abbreviations

AFE	Anti-ferroelectricity
Å	Angstrom
BE	Binding energy
^{o}C	Degree Celsius
EDS	Energy dispersive spectroscopy
FE	Ferroelectricity
FWHM	Full width half maxima
Hrs	Hours
ICDD	International centre for diffraction data
kHz	Kilohertz
MHz	Megahertz
Min	Minute(s)
MPB	Morphotropic phase boundary
Nm	Nano-meter
P	Polarization
E	Electric field
PT	Lead titanate
PVA	Polyvinyl alcohol
SEM	Scanning electron microscope
T	Temperature
XPS	X-ray photoelectron spectroscopy
XRD	X-ray diffraction